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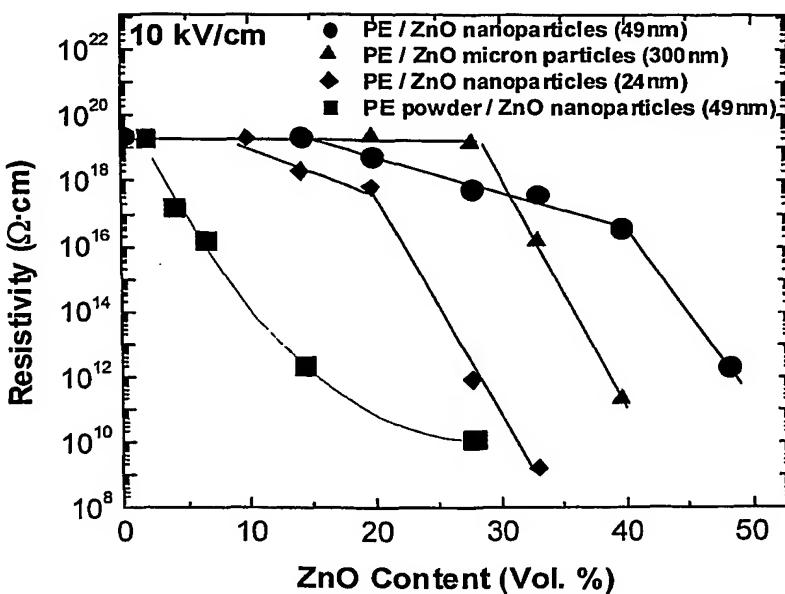
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(57) Abstract: A field grading material includes a field grading effective amount of a nanoparticle filler distributed in a polymeric matrix, and the nanoparticle filler is heterogeneously distributed in the polymeric matrix.

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